

Notice of References Cited	Application/Control No. 10/576,248		Applicant(s)/Patent Under Reexamination SHINOHARA ET AL.	
	Examiner Andrew K. Bohaty		Art Unit 4132	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2004/0018386 A1	01-2004	Naito et al.	428/690
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	WO 0041443 A1	07-2000	World Intellect	AZUMA H et al.	
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NON-PATENT DOCUMENTS

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	U	Clevius P VP CH8000. H. C. Starck chemical website, www.ampertec.info. Accessed on 07/09/2009.
	V	Baytron P VP CH800. H. C. Strack chemical. Issue date: 06/09/2002.
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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